


<b>Search Notes</b>  	<b>Application/Control No.</b>  10786915	<b>Applicant(s)/Patent Under Reexamination</b>  HAN, TIANG FONG
	<b>Examiner</b>  David T Fidei	<b>Art Unit</b>  3728

SEARCHED			
Class	Subclass	Date	Examiner
206	459.1, 459.5, 575, 722, 724, 725	1/31/08	dtf
	Update above	1/31/08	dtf

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	PGPub text search - see interference printout	1/31/08	dtf